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# Microwave Materials Effects of Temperature and Frequency On The Dielectric Constant Teflon

Michael A. Blaugher

*Indiana University - Purdue University Fort Wayne*

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**MICROWAVE MATERIALS**

**Effects of  
Temperature  
and  
Frequency**

**On The  
Dielectric Constant  
Teflon (PTFE)**

Prepared For  
Professor R. Emery  
Purdue University, EET  
Ft. Wayne, IN

By  
Michael A Blaugher

APRIL 24, 1994

**CONTENTS**

	Page #
Letter of Transmittal . . . . .	i
Introduction . . . . .	1
Manufacture and Product Data . . . . .	2
Definitions . . . . .	3
Equipment Required . . . . .	4
Procedures . . . . .	4
Measurement of Return Loss . . . . .	5
Measurement of Insertion Loss . . . . .	6
Final Results . . . . .	7
Conclusion . . . . .	8
Works Cited . . . . .	9
Appendix: Graphs . . . . .	10-14